PATENT

Docket No.: 060188-062

ATENT AND TRADEMARK OFFICE IN THE UNIX

In re Application of

Customer Number: 20277

Koei HATADE, et al.

Confirmation Number: 8814

Application No.: 10/635,649

Group Art Unit: 2627

Filed: August 07, 2003

Examiner: Van T. Pham

For: OBJECT LENS FOR OPTICAL PICKUP AND METHOD FOR DESIGNING THE SAME

INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed more than three months after the U.S. filing date AND after the mailing date of the first Office Action on the merits, but before the mailing date of a Final Rejection or Notice of Allowance.

10/635,649

CERTIFICATION PARAGRAPH

The undersigned certifies that each item of information contained in this Information

Disclosure Statement was first cited in a communication from a foreign patent office in a

counterpart foreign application not more than three months prior to the filing of this Information

Disclosure Statement as described in 37 CFR 1.97(e)(1).

Each non-English language reference was cited in a corresponding foreign application

office action and its relevance discussed therein. A copy of the foreign office action, together

with an English language version thereof, is attached for the Examiner's information.

Please charge any shortage in fees due in connection with the filing of this paper,

including extension of time fees, to Deposit Account 500417 and please credit any excess fees to

such deposit account.

Respectfully submitted,

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Date: June 20, 2006

as our/correspondence address.

Please recognize our Customer No. 20277

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	CIT	ATION DISCLOS ATION IN AN PPLICATION	ATTY. DOCKET NO. 060188-0629		SERIAL NO. 10/635,649			
(PTO-1449) EXAMINER'S CITE Document Number Publication Date				APPLICANT Koei HATADE, et al.				
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EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes -Number 4 -Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear		Transla Yes	ation N o
		JP 2001-076367 A	03/23/2001	ASAHI OPTICAL CO LTD			JAPAN (w/ English abstract)	
		JP 09-270145 A	10/14/1997	SONY CORP			JAPAN (w/ English abstract)	
		JP 10-021574 A	01/23/1998	NEC CORP			JAPAN (w/ English abstract)	
		JP 2002-056569 A	02/22/2002	MATSUSHITA ELECTRIC IND CO LTD			JAPAN (w/ English abstract)	
		JP 10-255305 A	09/25/1998	HITACHI LTD			JAPAN (w/ English abstract)	
		JP 07-302437 A	11/14/1995	TOSHIBA CORP			JAPAN (w/ English abstract)	
		JP 2000-306258 A	11/02/2000	TOSHIBA ELECTRONIC ENGINEERING CORP			JAPAN (w/ English abstract)	
		JP 06-163988 A	06/10/1994	SHARP CORP			JAPAN (w/ English abstract)	
		JP 2000-011417 A	01/14/2000	TOSHIBA CORP			JAPAN (w/ English abstract)	
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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.